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Lead-free double perovskite $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$): insights into the optical, dielectric, and charge transfer properties

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Recently, double perovskites have shown excellent potential considering the instability and toxicity problems of lead halide perovskites in optoelectronic devices. Here, the double perovskites $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) were successfully synthesized *via* the slow evaporation solution growth technique. The cubic phase of these double perovskite materials was verified through the X-ray diffraction pattern. The investigation of $\text{Cs}_2\text{CuBiCl}_6$ and $\text{Cs}_2\text{AgBiCl}_6$ utilizing optical analysis showed that their respective indirect band-gap values were 1.31 and 2.92 eV, respectively. These materials, which are double perovskites, were examined using the impedance spectroscopy technique within the 10^{-1} to 10^6 Hz frequency and 300–400 K temperature ranges. Jonncher's power law was utilized to describe AC conductivity. The outcomes of the study on charge transportation in $\text{Cs}_2\text{MBiCl}_6$ (where $M = \text{Ag}, \text{Cu}$) suggest that the non-overlapping small polaron tunneling mechanism was present in $\text{Cs}_2\text{CuBiCl}_6$, whereas the overlapping large polaron tunneling mechanism was present in $\text{Cs}_2\text{AgBiCl}_6$.

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1. Introduction

Thanks to their excellent optoelectronic properties, the well-known all-inorganic lead halides CsPbX_3 ($X = \text{Br}, \text{Cl}, \text{and I}$) have been considered to be amongst the most potential optoelectronic materials.^{1–6} Different devices such as lasers, photo-detectors, solar cells, and light-emitting diodes (LED)^{7–9} on the basis of lead-based perovskite compounds have been widely investigated. However, the toxic nature of lead and the instability of halide perovskite compounds under light conditions, high temperature, and moisture restrict the use of lead-halide perovskites in the future.^{10–12} Consequently, due to these problems, searching for non-toxic and stable lead-free perovskite candidates with good optoelectronic characteristics is among the most current research topics in the optoelectronics area.

Current research has proved that the replacement of two divalent Pb^{2+} ions by a couple of trivalent and monovalent metal ions is a good way to resolve the stability and toxicity problems,¹³ in which the double perovskite compounds are developed with the well-known family $\text{A}_2\text{MM}'\text{X}_6$ ($A = \text{Rb}^+, \text{Cs}^+, \text{etc.}$; $M = \text{Ag}^+, \text{K}^+, \text{Li}^+$; $M' = \text{Sb}^{3+}, \text{In}^{3+}$ or Bi^{3+} and $X = \text{I}^-, \text{Br}^-$ or Cl^-).^{14,15} Especially, these families have drawn special consideration owing to their great moisture, thermal and light stability, and hence have been predicted as excellent replacements for lead-

halide perovskites.¹⁴ Nevertheless, as compared to lead-halide perovskite, the majority of double perovskite materials show either the indirect bandgap with parity-forbidden transitions, which cause the weak photoluminescence behavior, or the wide indirect bandgap.¹⁵

Several investigations have focused on the synthesis and optical/optoelectronic studies of double perovskite materials,¹⁶ in which charge transport plays a significant role in the efficiency of electrical and optoelectronic devices. Nonetheless, a comprehensive comprehension of the electrical transport mechanism and dielectric properties of $\text{A}_2\text{MM}'\text{X}_6$ remains elusive.

The investigation of dielectric relaxation and AC conduction mechanisms across a broad range of temperatures and frequencies is typically conducted using dielectric spectroscopy.¹⁷ By analyzing multiple parameters such as AC conductivity, electrical modulus, dielectric permittivity, and complex impedance, the dielectric properties of a material can be studied, providing a qualitative representation that yields valuable insights. For example, the presence or absence of a relaxation peak in the imaginary modulus plots can indicate whether a material exhibits localized conduction (dielectric relaxation) or non-localized (long-range conductivity) processes. Furthermore, the relaxation time and activation energy for $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) can be used to define specific transport mechanisms.¹⁸ The dielectric behavior has been studied in various materials such as conducting glasses, ionically conducting polymers, amorphous transition metal oxide semiconductors, and perovskite oxide materials.¹⁹

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This paper presents the synthesis, optical, and structural characterizations of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$). As these perovskites have not been extensively studied, this study provides a comprehensive investigation of their electrical and dielectric properties. To study the dielectric properties, impedance spectroscopy was used, which is a practical tool to analyze these properties. The dielectric study of the material as a function of frequency and temperature can provide detailed information on the conduction mechanism, loss factor, permittivity, and localized charge carriers. There is limited literature available on the research conducted on the AC conductivity and dielectric relaxation of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$). In this work, the study of dielectric relaxation was conducted carefully as a function of temperature and frequency along with the conductivity of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$), electrical modulus, and impedance spectroscopy. The results of the dielectric research were analyzed using various theoretical models. Additionally, detailed discussions on the dielectric constant, dielectric loss, AC and DC conductivity, as well as the electrical modulus and impedance study of these double perovskite materials are reported in this paper.

2. Experimental section

2.1. Materials

Silver chloride (Sigma-Aldrich, 99%), bismuth(III) chloride (Sigma-Aldrich, $\geq 98\%$), copper(I) chloride (Sigma-Aldrich, $\geq 99\%$), and cesium chloride (Sigma-Aldrich, $\geq 98\%$) were utilized without any additional purification treatment.

2.2. Synthesis

The single crystals of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu}, \text{Ag}$) were prepared using the slow solvent evaporation method as follows: a mixture of bismuth(III) chloride (0.839 g, 0.0026 mol/0.792 g, 0.0025 mol), cesium chloride (0.896 g, 0.0053 mol/0.846 g, 0.0050 mol), and copper(I)/silver chloride (0.263 g, 0.0026 mol/0.360 g, 0.0025 mol) was combined in 50 mL of deionized water at room temperature. Over several days, the solvent in the resulting solution, which contained the precursors for the double perovskite, gradually evaporated, resulting in the formation of single crystals of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu}, \text{Ag}$). The utilization of the evaporation method offers numerous benefits, including advantages such as homogeneity and cost-effectiveness, among others.¹⁸

2.3. Characterization

To obtain fine powders for powder X-ray diffraction (PXRD) analysis, a small amount of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) crystals was ground using an agate mortar and pestle. PXRD analysis was conducted at room temperature using a Rigaku MiniFlex 600 benchtop diffractometer, with a Cu K_α line radiation ($\lambda = 1.54 \text{ \AA}$) in the 2θ range of $10\text{--}50^\circ$ and a step size of 0.04° .

A PerkinElmer Pyris 6 instrument was used to conduct thermogravimetric (TG) analysis on the powders obtained from $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) crystals. The analysis was performed at

different heating rates, from 0 to 1200°C , in a closed perforated aluminum pan.

A PerkinElmer Lambda 950 UV-Vis spectrophotometer was used to measure the diffuse reflectance in the ultraviolet-visible region. The UV-Vis absorption spectrum was obtained at room temperature using a single crystal of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$).

A small quantity of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) crystals was ground into fine powders using a pestle and agate mortar for complex impedance measurement. Pellets of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) with a thickness of approximately 1 mm were formed under a 50 Torr pressure and room temperature using an 8 mm hydraulic press. To ensure good electrical contact, silver paint was applied to the samples and they were placed between two copper electrodes. The AC conductivity and dielectric relaxation were measured using a TH2828A impedance analyzer at a frequency range of 10^{-1} to 10^6 Hz and a 2 K min^{-1} heating rate connected to a temperature controller (TP94, Linkam, Surrey, UK) at temperatures ranging from 300 to 400 K. The applied AC voltage was 0.5 V.

3. Results and discussion

The crystal structures of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) were obtained at ambient temperature through powder X-ray diffraction. Fig. 1(a) illustrates the diffractograms. Celref3 software was used to index all reflection peaks *via* the least squares method utilizing the powder data. The PXRD analysis confirmed that $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) adopted a cubic double perovskite structure with $Fm\bar{3}m$ space group symmetry. The unit cell parameters are $a = 10.775$ (8) \AA and $a = 10.364$ (6) \AA ($\alpha = \beta = \gamma = 90.00^\circ$) for $\text{Cs}_2\text{AgBiCl}_6$ and $\text{Cs}_2\text{CuBiCl}_6$, respectively. The parameters obtained for both compounds align with the information found in the bibliography.^{20,21} The photophysical properties of a material are intricately tied to its crystal structure. The literature suggests that double perovskites feature a three-dimensional arrangement of interconnected octahedra, where the cuboctahedral voids in the structure are filled with Cs^+ ions.²² The structure of double perovskites is composed of octahedra centered on Cu^+/Ag^+ and Bi^{3+} ions, which alternate in all three directions, forming a superstructure commonly known as rock salt ordering. The crystal structure of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu}, \text{Ag}$) exhibits a rock salt order structure, where alternating octahedral units of $[\text{BiCl}_6]^{3-}$ and $[\text{MCl}]^{5-}$ are present. At the center of the cuboctahedra, there is a Cs^+ ion, as depicted in Fig. 1(b).

The perovskites under consideration have been characterized with an electronic dimensionality of 0D due to the spatial separation observed between the $[\text{MCl}_6]^{5-}$ and $[\text{BiCl}_6]^{3-}$ octahedra. This 0D electronic dimensionality leads to the confinement of photoexcited charge carriers, resulting in high effective masses of charge carriers.²³

In light of the significance of thermal stability as a crucial property for future applications of halide perovskites, we conducted thermogravimetric analysis on $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu}, \text{Ag}$) powder samples prepared for this study (Fig. 1(c)). Our analysis revealed a noticeable weight loss occurring in two distinct stages.

The initial stage weight loss was observed in the temperature range of $446/501$ to $800/725^\circ\text{C}$ and can be attributed to the



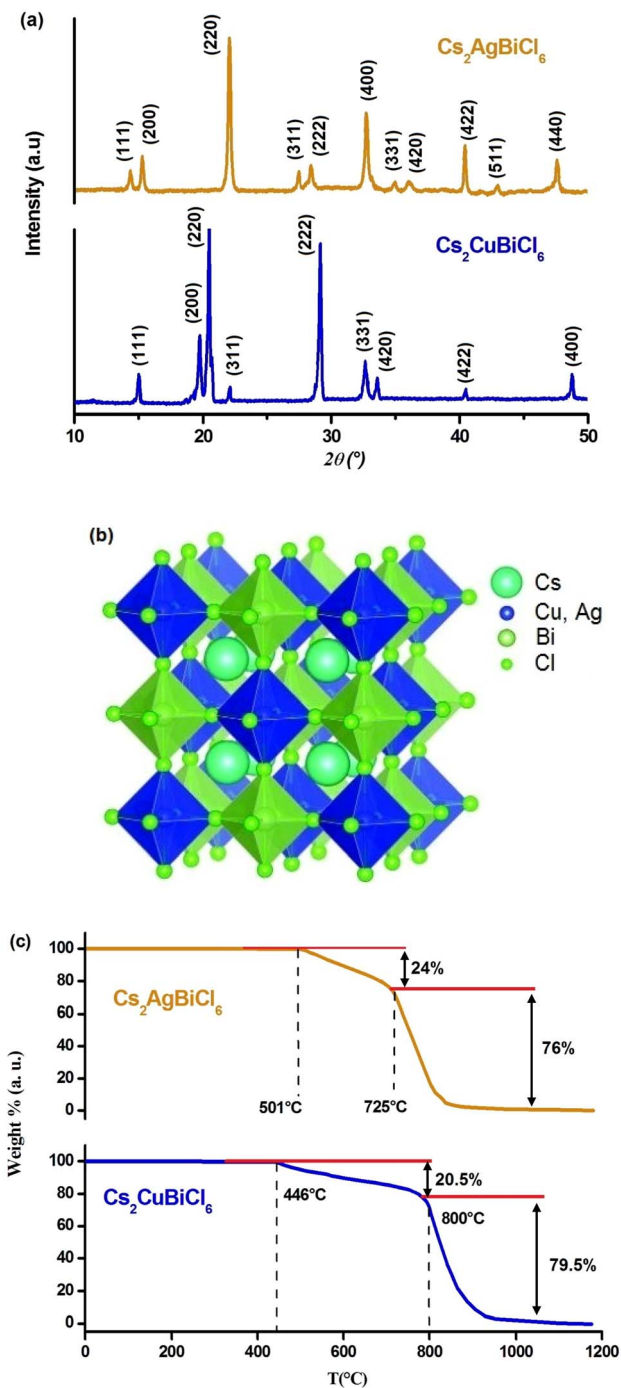


Fig. 1 (a) Powder X-ray diffractogram of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$) at room temperature in the 2θ range $10\text{--}50^\circ$. (b) Constructed cubic crystal structure of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$). (c) TG data of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$) in the temperature range of $100\text{--}1190\text{ K}$.

evaporation of CsMCl_2 ($M = \text{Cu, Ag}$).²⁴ Hence, the decomposition process can be described as follows: $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$) \rightarrow $\text{CsMCl}_2 + \text{CsBiCl}_4$. The subsequent weight loss of 76/79.5 wt% at $800/725^\circ\text{C}$ is associated with the evaporation of CsCl and MCl ($M = \text{Cu, Ag}$).²⁴ The decomposition reaction can be represented by the following scheme: $\text{CsBiCl}_4 \rightarrow \text{CsCl} + \text{BiCl}_3$.

The findings presented above suggest that $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$) exhibits a notable level of stability up to approximately $446/501^\circ\text{C}$, which holds significant implications for its extensive applications in optoelectronic and photochemical fields.²⁵ However, beyond this temperature, noticeable decomposition reactions take place, leading to the complete loss of material functionality.

The optical absorption of $\text{Cs}_2\text{MBiCl}_6$ compounds (where $M = \text{Ag, Cu}$) was estimated within a wavelength range of $300\text{--}800\text{ nm}$ using a UV-Vis spectrophotometer (Fig. 2(a) and (b)). We have determined an indirect bandgap (E_g) of 1.31 eV and 2.91 eV for $\text{Cs}_2\text{CuBiCl}_6$ and $\text{Cs}_2\text{AgBiCl}_6$ (inset in Fig. 2(a) and (b)) by Tauc relation, which is expressed as:^{26–30}

$$\alpha = \frac{\beta}{h\nu} (h\nu - E_g)^n \quad (1)$$

where α is the optical absorption coefficient, β is a constant representing the degree of disorder, and n shows the power factor, which indicates the transition mode.

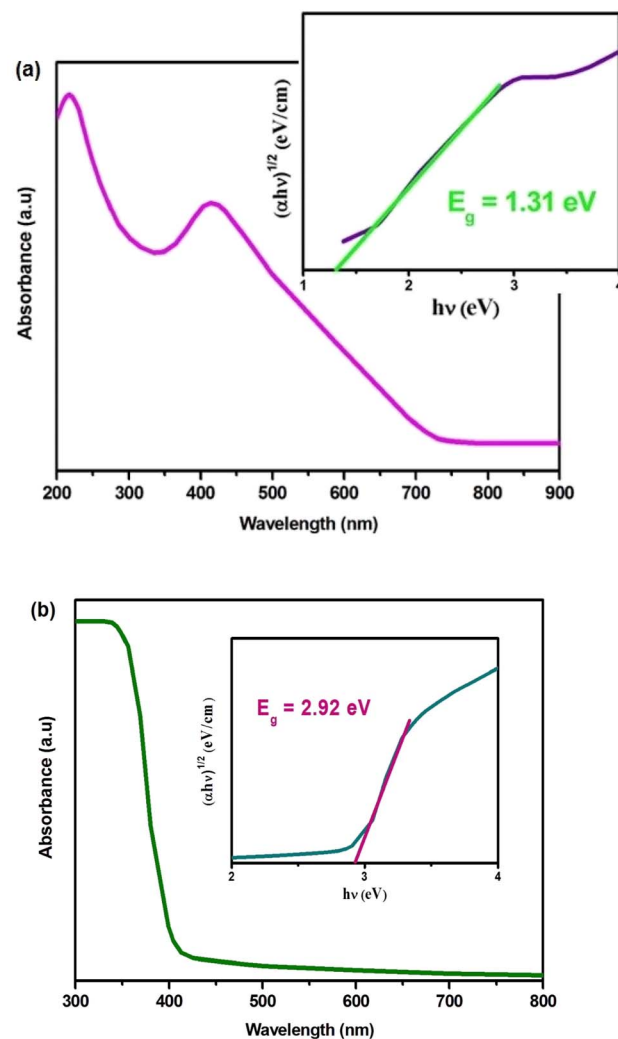


Fig. 2 Absorption spectra of (a) $\text{Cs}_2\text{CuBiCl}_6$ and (b) $\text{Cs}_2\text{AgBiCl}_6$. The inset shows the Tauc plot.



The significant absorption observed in the visible region indicates that $\text{Cs}_2\text{MBiCl}_6$ (where $\text{M} = \text{Ag}, \text{Cu}$) materials have the ability to effectively harness solar energy, enabling the generation of an ample number of photoinduced electron–hole pairs.²⁵ This characteristic promotes photoactivity by facilitating the desired reactions.²⁵

Based on the Tauc formula presented below, it is possible to estimate the optical bandgap E_g :

$$(\alpha h\nu)^{1/n} = \beta(h\nu - E_g) \quad (2)$$

When $n = 2$, the best plots are obtained by plotting $(\alpha h\nu)^2$ and $(\alpha h\nu)^{1/2}$ against photon energy ($h\nu$), leading to the most satisfactory results. In accordance with the Tauc equation, the indirect transition was then chosen:

$$(\alpha h\nu)^2 = \beta(h\nu - E_g) \quad (3)$$

The bandgap E_g value can be determined by extrapolating the linear portion to $\alpha = 0$,³¹ as demonstrated in the inset of Fig. 2(a) and (b) with E_g values of 1.31 eV and 2.91 eV for $\text{Cs}_2\text{-CuBiCl}_6$ and $\text{Cs}_2\text{AgBiCl}_6$, respectively, these materials are promising candidates for optoelectronics.

The following equation can be used to determine the optical bandgap transition mode of our compound:³²

$$\ln(\alpha h\nu) = \ln(\beta) + n \ln(h\nu - E_g) \quad (4)$$

The plots of $\ln(\alpha h\nu)$ vs. $\ln(h\nu - E_g)$ are shown in Fig. 3(a) and (b). The slope of the resulting straight line indicates the power factor (n), which identifies the type of optical transition mode.³² Using eqn (5) and the data from Fig. 3(a) and (b), we obtained the following linear relationships:

$$\ln(\alpha h\nu) = 16.69 + 1.98 \ln(h\nu - 1.31); (n \approx 2) (\text{Cs}_2\text{CuBiCl}_6) \quad (5)$$

$$\ln(\alpha h\nu) = 14.07 + 1.92 \ln(h\nu - 2.92); (n \approx 2) (\text{Cs}_2\text{AgBiCl}_6) \quad (6)$$

Thus, the indirect transition modes of the optical band of $\text{Cs}_2\text{CuBiCl}_6$ and $\text{Cs}_2\text{AgBiCl}_6$ were confirmed, as shown by the calculated transition power factor (n) values, which were found to be close to 2, in agreement with the expected modes.

The temperature-dependent behavior of the real part (Z') of the complex impedance with varying frequencies is depicted in Fig. 4(a) and (b) for different temperatures. As temperature and frequency increase, Z' decreases, indicating the negative temperature coefficient of resistance (NTCR) behavior in both $\text{Cs}_2\text{MbiCl}_6$ ($\text{M} = \text{Ag}, \text{Cu}$) materials.^{33,34} This behavior suggests that the AC conductivity may increase due to a decrease in the trapped charge density and an increase in the mobility of charge carriers within the material. At high frequencies, the temperature-independent behavior of Z' indicates the presence of space charge in both materials. The reduction in the relaxation time of the space charge at higher frequencies results in the merging of curves due to the collapse of space charge polarization.³⁵ The graphs in Fig. 5(a) and (b) illustrate the variation of the loss factor (Z'') in both double perovskite materials across

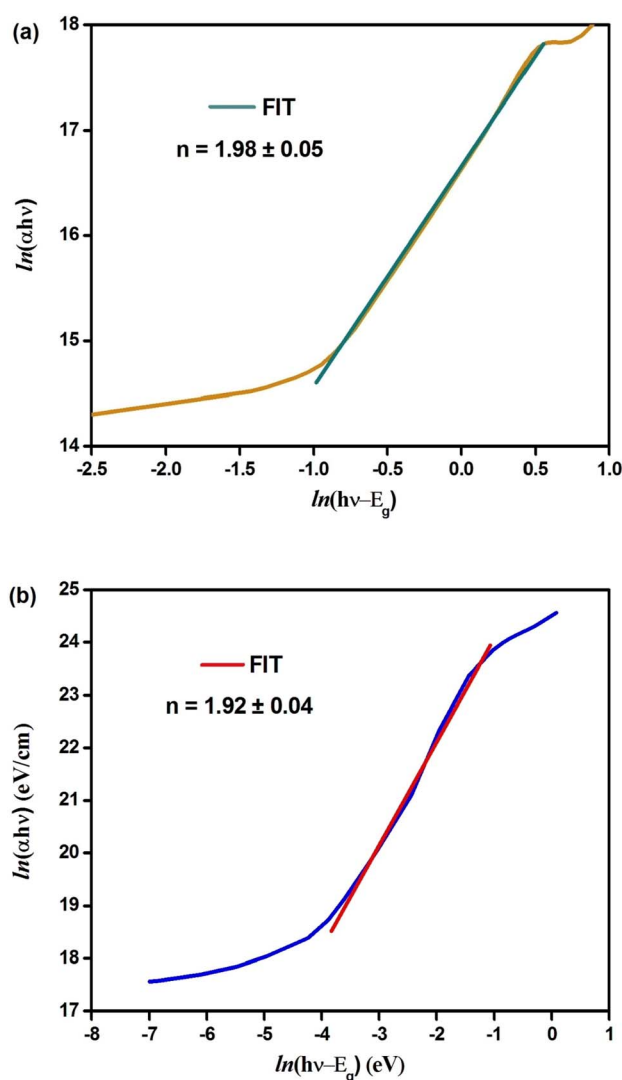


Fig. 3 Curves of $\ln(\alpha h\nu)$ vs. $\ln(h\nu - E_g)$ for (a) $\text{Cs}_2\text{CuBiCl}_6$ and (b) $\text{Cs}_2\text{AgBiCl}_6$.

the frequency range and various temperatures. These variations provide insight into the relaxation process and the fundamental charge transport mechanism of the materials. At high temperatures, the relaxation process is caused by defects or vacancies, while at low temperatures, it is due to immobile species or electrons. Each spectrum shows a distinct characteristic peak known as the “relaxation frequency.” The broadness of the peak suggests a deviation from the ideal Debye nature. The charge carrier motion over a long range is the main cause of transportation below the loss peak frequency, while above the relaxation frequency, the movement of the localized carriers is promoted. The relaxation peak shifts towards the high-frequency range with an increase in temperature, indicating a thermally dependent relaxation mechanism. The peak height decreases with temperature, suggesting a decline in grain and grain boundary resistance with temperature.³⁶

Fig. 6(a) and (b) depict the Cole–Cole plot between 300 and 400 K. It is worth noting that the centers of the depressed



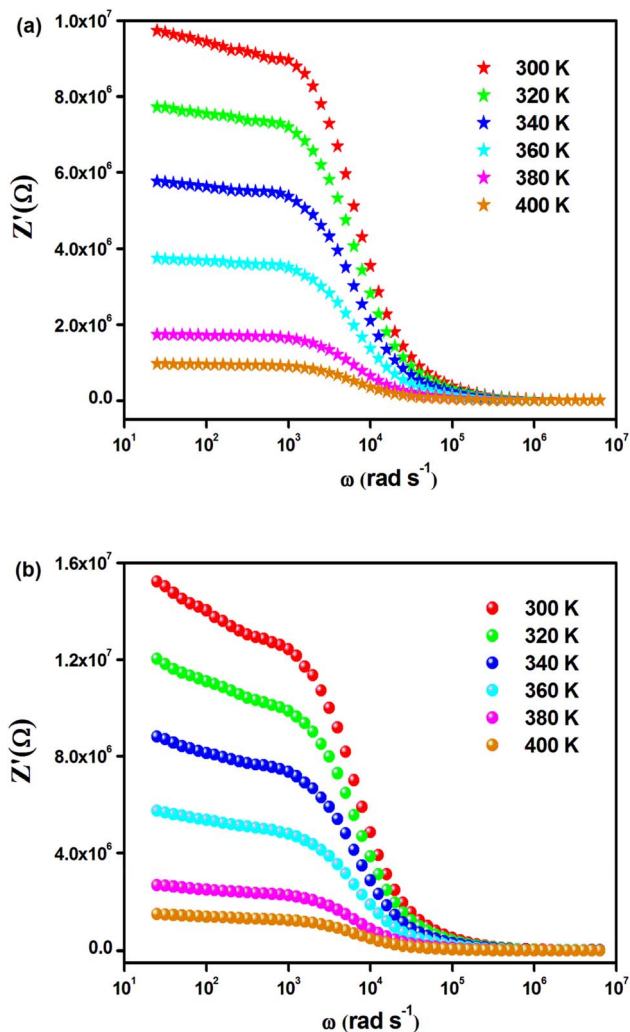


Fig. 4 Frequency dependence of $Z'(\omega)$ for (a) $\text{Cs}_2\text{CuBiCl}_6$ and (b) $\text{Cs}_2\text{AgBiCl}_6$ at various temperatures.

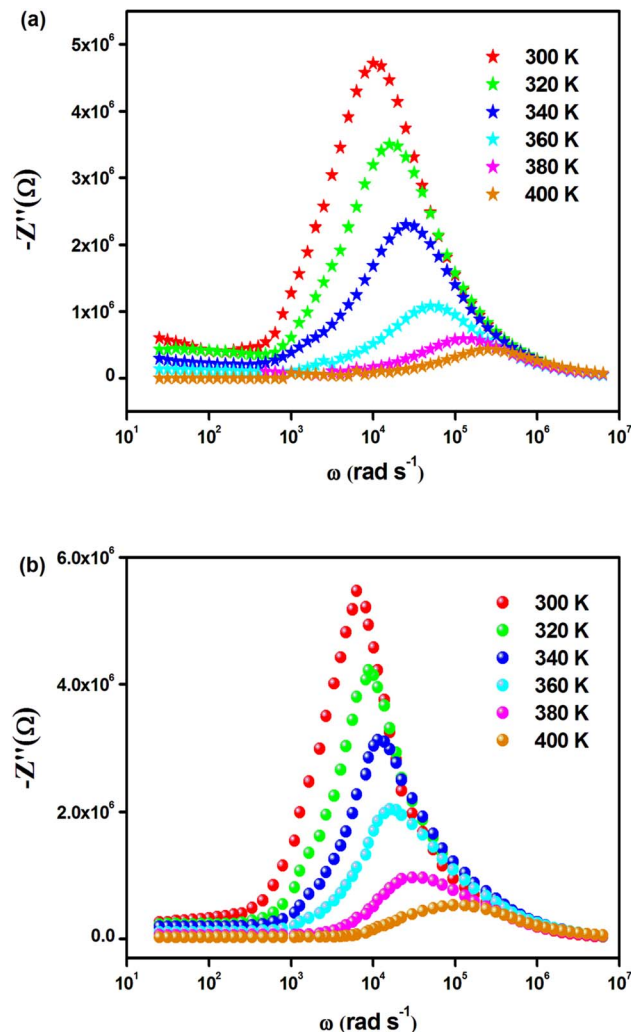


Fig. 5 Frequency dependence of $Z''(\omega)$ for (a) $\text{Cs}_2\text{CuBiCl}_6$ and (b) $\text{Cs}_2\text{AgBiCl}_6$ at various temperatures.

semicircles lie below the real axis, indicating that both materials exhibit non-Debye behavior. Additionally, as the temperature increases in the Cole–Cole plot, the radii of the semicircles decrease, providing further evidence of the NTCR behavior of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$).^{36,37} This suggests that these compounds exhibit properties of semiconductors and that the conduction mechanism is thermally activated. The Nyquist plot ideally displays three separate semicircles that represent the contribution of the grains, grain boundaries, and electrode-material interface. The semicircle observed in the high-frequency region corresponds to the contribution of the grains, while the semicircle in the low-frequency region corresponds to the contribution of the grain boundaries. Additionally, the semicircle in the ultra-low-frequency region confirms the contribution of the electrode-material interface. Distinguishing the contribution of grains and grain boundaries from a single depressed semicircle is difficult. To solve this problem, researchers have used the Maxwell–Wagner equivalent circuit model, which is made up of a parallel combination of resistors (R) and capacitors (C). To obtain the desired circuit model for $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$), two

parallel RC elements are connected in series. The ZView software is used to fit the impedance spectra of all temperatures. In addition, a constant phase element (CPE) is used to interpret the straight line that follows the semicircle, which depends on the double layer capacity of an inhomogeneous electrode surface (see the insets in Fig. 6(a) and (b)). Fig. 6(a) and (b) depict a significant decrease in the diameter of the semicircle and its intersection point on the real axis with an increase in temperature, indicating an enhancement in DC conductivity of $\text{Cs}_2\text{-MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$).³⁸ A schematic representation of the grains and grain boundaries is depicted in Fig. 6(c). To evaluate these parameters, the experimental data were fitted using the ZView software. Table 1 shows that R_{gb} values are higher than R_{g} values at all temperatures, implying that grain boundaries have a greater contribution to the total resistance. This difference between the resistive values causes an increase in the number of space charges at the grain boundaries due to polarization, leading to the Maxwell–Wagner effect.³⁹ It is well known that grain boundaries are more resistive than grains in perovskite materials.¹⁷



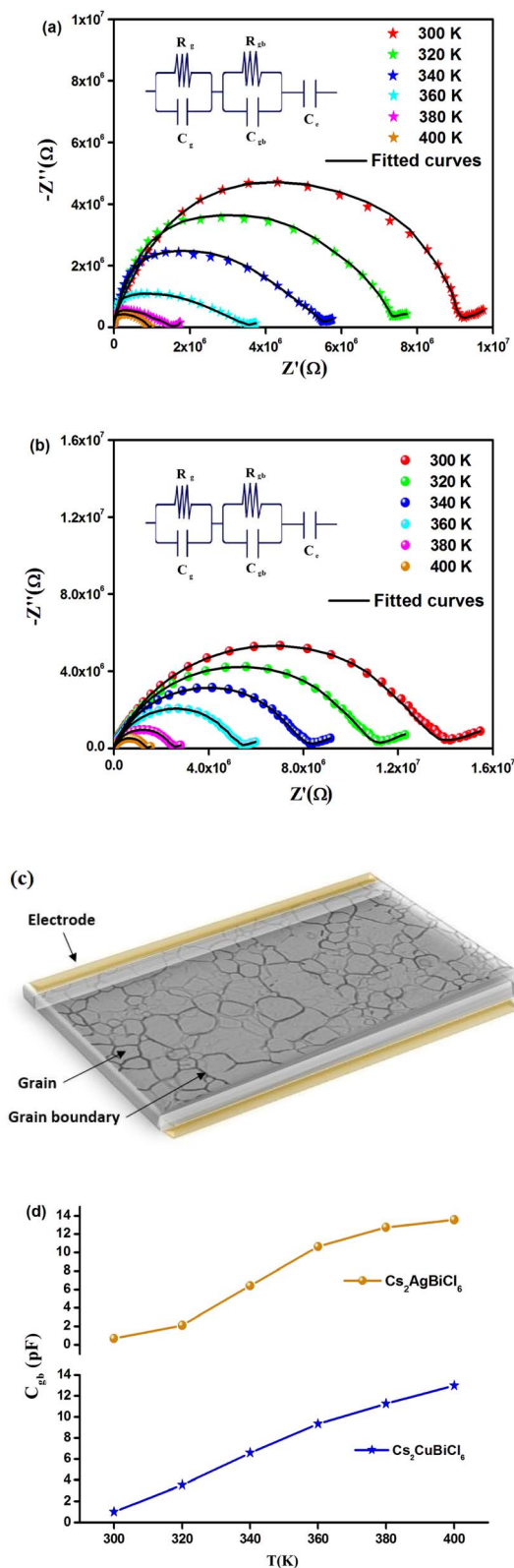


Fig. 6 Fitted Cole–Cole plots of (a) $\text{Cs}_2\text{CuBiCl}_6$ and (b) $\text{Cs}_2\text{AgBiCl}_6$ at different temperature, (the equivalent circuits have shown in inset). (c) Representation of grain and grain boundary within material. (d) The variation of C_{gb} of $\text{Cs}_2\text{MBiCl}_6$ (M = Cu, Ag) at different temperatures.

The trends in grain boundary capacitance (C_{gb}) with temperature are shown in Fig. 6(d) for both materials. The expression for C_{gb} is given by $C_{gb} = (\epsilon_{gb}A)/d$, where ϵ_{gb} represents the intrinsic dielectric constant at the grain boundary, A is the area of the grain boundary, and d is the barrier-layer width. The barrier-layer width is proportional to the ratio of the trapped charge carriers to free carrier density.¹⁷ As temperature increases, trapped charge carriers decrease, resulting in a smaller barrier-layer width. Consequently, the grain boundary capacitance increases with temperature due to this behavior.

The investigation of the dielectric constants within the temperature range of 300 to 400 K and as a function of frequency is demonstrated in Fig. 7(a)–(d). It is shown that the dielectric constant in the low-frequency region is significant at a specific temperature and declines gradually with an increase in frequency for both materials. The ionic conduction process is influenced by both $\epsilon'(\omega)$ and $\epsilon''(\omega)$ and is driven by four types of polarization; namely, interfacial, orientational, electronic, and ionic polarization. Interfacial and orientational polarizations refer to the relaxation component of polarizability, whereas electronic and ionic polarizations represent the deformational component of polarizability.⁴⁰ The changes in the real part of permittivity with frequency are influenced by Maxwell–Wagner interfacial polarization, which is consistent with Koop’s phenomenological theory.⁴¹ This theory suggests that the material contains conducting grains separated by poorly conducting grain boundaries, resulting in trapped charge carriers at the interfaces of grain boundaries and hindering their flow.^{41,42} The interfacial polarization process involves the exchange of electrons between the ions of the same molecules. Imperfections and deformities within the material result in changes in the position and distribution of positive and negative space charges. Under the influence of the applied electric field, positive charges move towards the negative poles, while negative charges move towards the positive poles.⁴³ It is observed that in the low-frequency range, these materials permit electrons to reach the grain boundary regime *via* hopping (Fig. 7(a) and (b)). However, due to the high resistance at the grain boundary, the electrons are accumulated at the grain boundary and induce polarization. On the other hand, at high frequencies, the electrons are unable to follow the changes in the applied field and as a result, they cannot accumulate further, even though they move in the opposite direction. Therefore, with decreasing polarization thickness, there is a reduction in the likelihood of electrons reaching the grain boundary as the frequency increases.¹⁸ In the mid-frequency region, the variation in $\epsilon'(\omega)$ may exhibit a hump due to the relaxation process. A temperature-dependent dielectric response is brought about by the shift of the hump position to the low-frequency region as the temperature increases. However, the value of $\epsilon'(\omega)$ at high frequency remains relatively unchanged. The “unrelaxed” value of permittivity indicates the contribution of atomic and electronic polarization. In the double perovskite material $\text{Cs}_2\text{MBiCl}_6$, polarization is primarily determined by the presence of Cs^+ , $[\text{MCl}_6]^{5-}$, and $[\text{BiCl}_6]^{3-}$ ions. As the temperature decreased, the real part of the dielectric constant $\epsilon'(\omega)$ also decreased. This could be attributed to the



Table 1 Parameters of the equivalent circuit at various temperatures

Temperature (K)	R_g (k Ω)	C_g (nF)	R_{gb} (k Ω)	C_{gb} (pF)	CPE _c (μ F)	α_c
Cs₂CuBiCl₆						
300	402	1.32	8904	1.00	0.98	0.575
320	302	1.45	7012	3.54	1.12	0.478
340	198	1.94	5786	6.57	1.47	0.486
360	87	2.12	4258	9.33	1.70	0.502
380	12	2.64	3112	11.25	1.96	0.511
400	0.77	2.80	1254	12.99	2.08	0.562
Cs₂AgBiCl₆						
300	756	1.05	11 355	0.68	0.47	0.685
320	541	1.65	9012	2.11	0.82	0.625
340	356	2.05	7452	6.39	1.05	0.574
360	105	2.97	5214	10.62	1.18	0.623
380	74	3.44	3879	12.73	1.25	0.542
400	3.56	4.61	2652	13.54	1.31	0.598

reduced mobility of conducting electrons and participating ions at lower temperatures.

One of the popular theoretical models, the modified Cole–Cole model, has been utilized along with DC conductivity to study the change in dielectric constant and dielectric loss with frequency for different temperatures. The complex permittivity can be expressed using the modified Cole–Cole model, as shown below:¹⁷

$$\varepsilon^* = \varepsilon_\infty + \frac{\varepsilon_s - \varepsilon_\infty}{1 + (j\omega\tau)^m} - \frac{j\sigma^*}{\varepsilon_0\omega^m} \quad (7)$$

$$\varepsilon' = \varepsilon_\infty + \frac{(\varepsilon_s - \varepsilon_\infty) \left\{ 1 + (\omega\tau)^\beta \cos\left(\frac{\beta\pi}{2}\right) \right\}}{1 + 2(\omega\tau)^\beta \cos\left(\frac{\beta\pi}{2}\right)} + \frac{j\sigma}{\varepsilon_0\omega^m} \quad (8)$$

The symbol σ^* denotes the combination of the conductivities of free charge carriers (σ_{fc}) and space charge carriers (σ_{sp}). The limit of permittivity at high frequency is represented by ε_∞ , while ε_s refers to the limit of permittivity at low frequency. The relaxation time is indicated by τ , and the frequency exponent is denoted by m . The modified Cole–Cole parameter, β , ranges

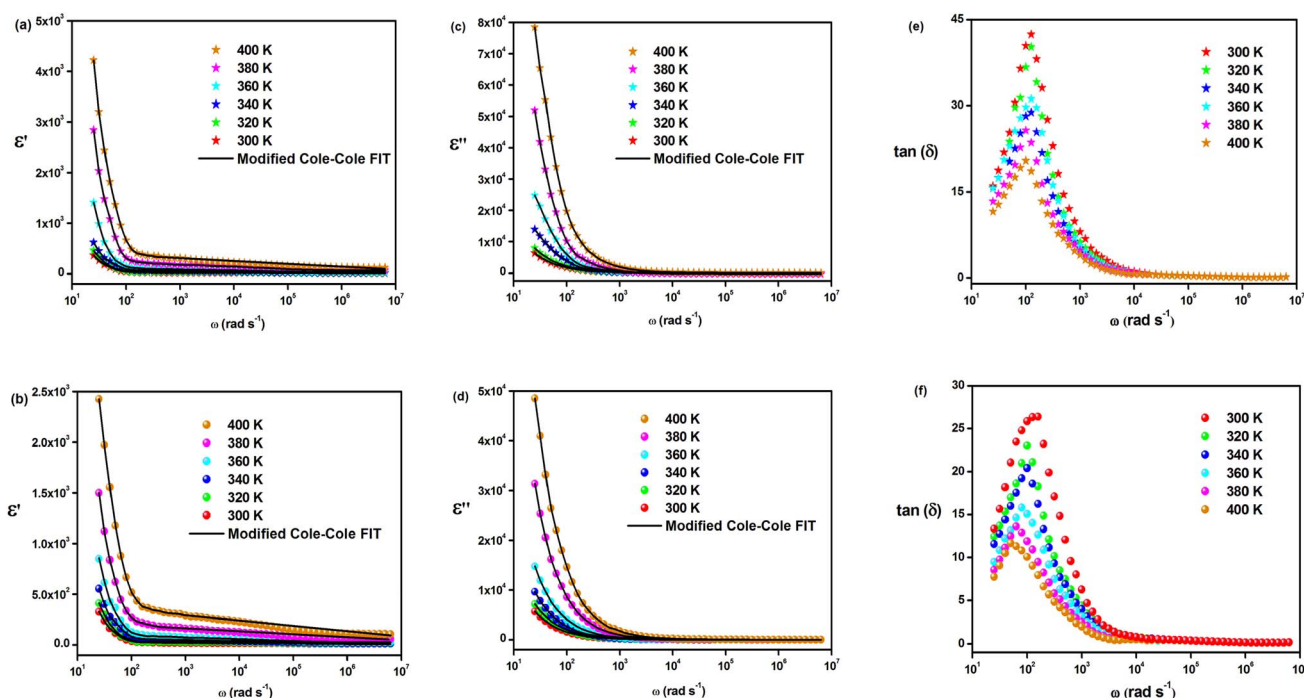


Fig. 7 Variation of $\varepsilon'(\omega)$ of (a) Cs₂CuBiCl₆ and (b) Cs₂AgBiCl₆ at different temperatures. Variation of $\varepsilon''(\omega)$ of (c) Cs₂CuBiCl₆ and (d) Cs₂AgBiCl₆ at various temperatures. Frequency-dependent dielectric loss ($\tan \delta$) of (e) Cs₂CuBiCl₆ and (f) Cs₂AgBiCl₆.



from 0 to 1. Eqn (9) and (10) demonstrate the real (ϵ') and imaginary (ϵ'') components of the dielectric constant.^{44,45}

$$\epsilon' = \epsilon_{\infty} + \frac{(\epsilon_s - \epsilon_{\infty}) \left\{ 1 + (\omega\tau)^{\beta} \cos\left(\frac{\beta\pi}{2}\right) \right\}}{1 + 2(\omega\tau)^{\beta} \cos\left(\frac{\beta\pi}{2}\right) + (\omega\tau)^{\beta}} + \frac{\sigma_{sp}}{\epsilon_0 \omega^m} \quad (9)$$

$$\epsilon'' = \frac{(\epsilon_s - \epsilon_{\infty}) (\omega\tau)^{\beta} \sin\left(\frac{\beta\pi}{2}\right)}{1 + 2(\omega\tau)^{\beta} \cos\left(\frac{\beta\pi}{2}\right) + (\omega\tau)^{\beta}} + \frac{\sigma_{fc}}{\epsilon_0 \omega^m} \quad (10)$$

The modified Cole–Cole equation was used to fit the experimental data of ϵ' and ϵ'' . The obtained values for various parameters such as β , m , σ_{sp} , σ_{fc} , and τ are presented in Table 2. It is evident from the table that the values of free charge conductivity (σ_{fc}) and space charge conductivity (σ_{sp}) for $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) increase as the temperature rises. The value of β , which ranges between 0 and 1, indicates the non-Debye nature. As the temperature increases, the relaxation time decreases.

The loss tangent refers to the ratio of the dielectric loss to the real part of the dielectric constant. Fig. 7(e) and (f) show the variation in the loss tangent with frequency for a specific temperature range ($\tan(\delta) = \epsilon''(\omega)/\epsilon'(\omega)$). $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag}, \text{Cu}$) exhibits a decrease in the loss tangent with increasing frequency, which ultimately becomes constant at a certain temperature in the high-frequency region. At low frequencies, the observed peaks are likely a result of dominant dipolar polarization. As the loss tangent values increase, the peaks shift with increasing temperature, providing evidence that dipolar polarization is influenced by temperature. The loss peak eventually appears when the hopping frequency corresponds to the frequency of an applied external AC field. Additionally, the hopping mechanism implies that as the temperature increases, the electrical conductivity also increases, leading to the activation of charge carriers through thermal means.

Fig. 8(a) and (b) demonstrate the frequency dependence of the real part of the electric modulus spectra for different temperatures. As shown in these figures, M' is nearly zero at low frequencies for all temperatures. This behavior can be attributed to the long-range mobility of charge carriers in the conduction mechanism and the neglect of electrode polarization. In addition, the sigmoidal nature of M' is evident. The peak of M' shows a slight shift towards higher frequencies as the temperature increases in the high-frequency region.

The variation in the imaginary part of the electric modulus spectra (M'') with frequency at different temperatures is depicted in Fig. 8(c) and (d). A peak occurs in M'' at a frequency that corresponds to the relaxation frequency, and at a certain temperature, M'' reaches its maximum value. There is no peak in the low-frequency region, while there is a significant peak in the high-frequency region. The charge carriers show successful hopping from one site to another, which enables them to move over a long distance in the low-frequency region. At high frequencies, the mobility of charge carriers is limited as they are confined within their potential well, causing them to move in a controlled manner. Hence, the appearance of peaks in the complex modulus spectra indicates the transition from long-range to short-range mobility of charge carriers. The shift of the peaks in the imaginary part of the electric modulus to higher frequencies with increasing temperature indicates the hopping mechanism. The non-Debye response of the sample is demonstrated by the asymmetric nature of the peaks in M'' . The asymmetric nature of the peaks is explained using the KWW equation, as shown in eqn (11):^{44,45}

$$M''(\omega) = \frac{M''_{\max}}{\frac{(1-c)}{(a+b)} \left[b \left(\frac{f}{f_{\max}} \right)^{-a} + a \left(\frac{f}{f_{\max}} \right)^b \right] + c} \quad (11)$$

The frequency at which M'' reaches its maximum value is denoted as f_{\max} , while the maximum value of M'' is represented by M''_{\max} . The two distinct parameters that shape the low-

Table 2 The parameters τ , β , m , σ_{sp} et. σ_{fc} were determined through fitting the modified Cole–Cole model to the frequency- and temperature-dependent dielectric constant and dielectric loss data

Parameter	Temperature					
	300 K	320 K	340 K	360 K	380 K	400 K
$\text{Cs}_2\text{CuBiCl}_6$						
τ	9.65×10^{-3}	5.32×10^{-3}	2.17×10^{-3}	7.91×10^{-4}	3.46×10^{-4}	8.87×10^{-5}
β	0.786	0.684	0.725	0.805	0.632	0.854
m	0.785	0.799	0.805	0.823	0.841	0.878
σ_{sp}	1.58×10^{-5}	4.74×10^{-5}	7.99×10^{-5}	2.66×10^{-4}	6.79×10^{-4}	1.41×10^{-3}
σ_{fc}	7.56×10^{-3}	5.69×10^{-3}	1.90×10^{-3}	8.57×10^{-2}	3.38×10^{-2}	9.85×10^{-1}
$\text{Cs}_2\text{AgBiCl}_6$						
τ	1.15×10^{-2}	6.08×10^{-3}	2.79×10^{-3}	9.53×10^{-4}	7.25×10^{-4}	4.67×10^{-4}
β	0.966	0.644	0.715	0.734	0.879	0.654
m	0.844	0.859	0.870	0.896	0.903	0.911
σ_{sp}	9.87×10^{-5}	3.54×10^{-4}	8.81×10^{-4}	2.07×10^{-3}	9.44×10^{-3}	2.79×10^{-2}
σ_{fc}	6.69×10^{-3}	1.73×10^{-3}	4.87×10^{-2}	8.45×10^{-1}	5.55×10^{-1}	2.13×10^{-1}



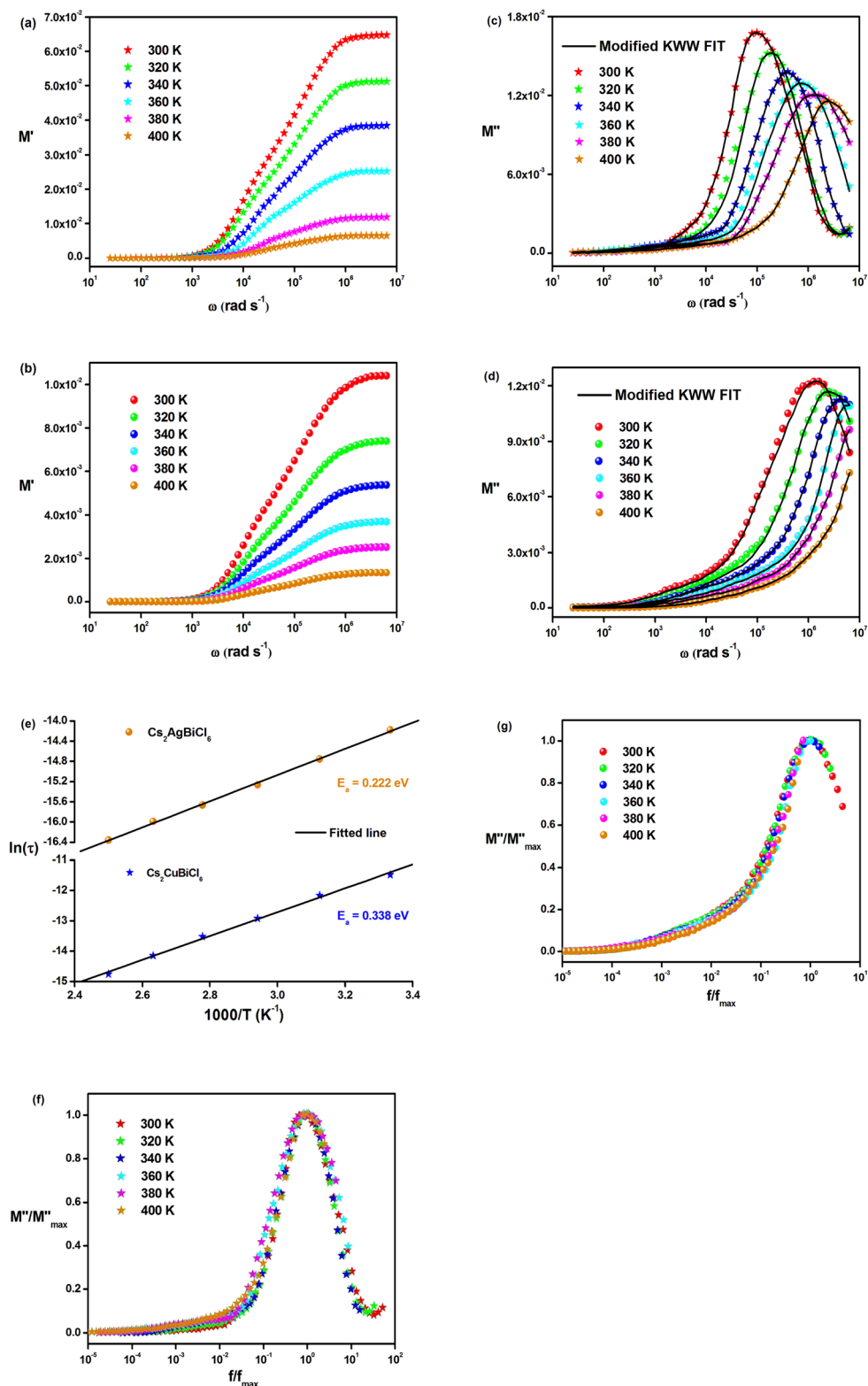


Fig. 8 Variation of $M'(\omega)$ of (a) $\text{Cs}_2\text{CuBiCl}_6$ and (b) $\text{Cs}_2\text{AgBiCl}_6$ at different temperatures. Variation of $M''(\omega)$ of (c) $\text{Cs}_2\text{CuBiCl}_6$ and (d) $\text{Cs}_2\text{AgBiCl}_6$ at various temperatures. (e) Arrhenius plots of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$). Normalized imaginary modulus M''/M''_{max} vs. f/f_{max} of (f) $\text{Cs}_2\text{CuBiCl}_6$ and (g) $\text{Cs}_2\text{AgBiCl}_6$ at various temperatures.

frequency and high-frequency sides are a and b , respectively. Additionally, c denotes the smoothing parameter. If $a = b = 1$ and $c = 0$, eqn (11) reduces to eqn (12), which corresponds to

the ideal Debye behavior and displays the symmetrical nature of M'' spectra with respect to frequency. Fig. 8(c) and (d) demonstrate that the modified KWW function fits well, as indicated by



Table 3 The parameters a and b were determined by fitting the modified Kohlrausch–Williams–Watts (KWW) function to $M''(\omega)$

Temperature (K)	a	b
Cs₂CuBiCl₆		
300	0.478	0.347
320	0.529	0.388
340	0.593	0.437
360	0.614	0.530
380	0.687	0.627
400	0.770	0.701
Cs₂AgBiCl₆		
300	0.547	0.572
320	0.653	0.602
340	0.741	0.640
360	0.798	0.681
380	0.802	0.704
400	0.825	0.712

the solid line. Table 3 provides the respective parameter values. The data show that, as the temperature rises, both a and b values increase, indicating that $M''(\omega)$ approaches an ideal Debye-type response at higher temperatures.

$$M''(\omega) = \frac{M''_{\max}}{\frac{1}{2} \left[\left(\frac{f_{\max}}{f} \right) + \left(\frac{f}{f_{\max}} \right) \right]} \quad (12)$$

Eqn (13) is utilized to determine the relaxation time (τ).

$$\tau = \frac{1}{f_{\max}} \quad (13)$$

The Arrhenius formula below is employed to calculate the average activation energies of the charge carriers:

$$\tau = \tau_0 \exp\left(-\frac{E_a}{k_B T}\right) \quad (14)$$

The activation energies of the charge carriers in Cs₂AgBiCl₆ and Cs₂CuBiCl₆ were determined using the Arrhenius equation (eqn (14)) and the $\ln(\tau)$ vs. $1000/T$ curves are shown in Fig. 8(e). The calculated activation energies were 0.222 eV and 0.338 eV, respectively. This suggests that the conduction mechanism in both materials is attributable to the thermally-stimulated charge carriers.⁴⁶

Fig. 8(f) and (g) depict the changes in the normalized imaginary part of the electric modulus and the normalized frequency of the samples at different temperatures. The peak positions in the normalized spectrum indicate a shift from long-range to short-range mobility of the charge carriers, as well as the hopping method of charge carriers, which was previously described in detail in the case of M'' spectra.⁴⁷ The peak coincidences at all temperatures suggest that the dynamic processes occurring in Cs₂MBiCl₆ (M = Ag, Cu) are independent of temperature.

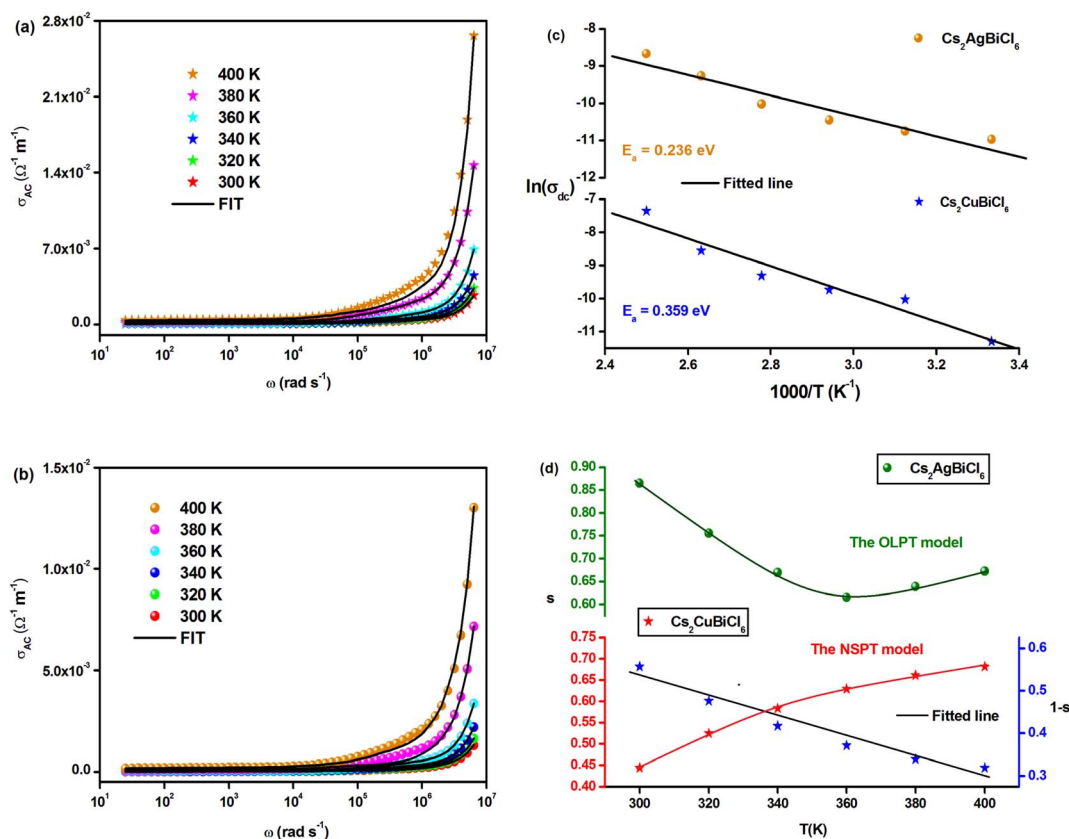


Fig. 9 The variation of σ_{ac} with frequency at different temperatures for (a) Cs₂CuBiCl₆ and (b) Cs₂AgBiCl₆. (c) Arrhenius plots of dc conductivity for Cs₂MBiCl₆ (M = Cu, Ag). (d) Temperature dependence of s and $1 - s$ for Cs₂MBiCl₆ (M = Cu, Ag).



Fig. 9(a) and (b) demonstrate the temperature-dependent changes in AC conductivity *versus* frequency. The AC electrical conductivity is estimated using the following formula: $\sigma_{ac} = \omega \epsilon' \epsilon_0 \tan \delta$, where ϵ_0 represents the permittivity of free space. AC conductivity contributes to the overall conductivity in the high-frequency range, while DC conductivity accounts for the calculated conductivity in the low-frequency range. The curves appear to flatten in this range due to the temperature-dependent and frequency-independent DC conductivity. However, the electrical conductivity curves increase significantly and exhibit significant frequency dispersion with increasing frequency, owing to the contribution of AC conductivity. The frequency at which the conductivity transition occurs in this type of behavior is referred to as “frequency hopping” (ω_p). As the temperature increases, ω_p shifts to the high-frequency range. Funke's jump relaxation model (JRM) can explain the observed frequency-dependent AC conductivity and frequency-independent DC conductivity.⁴⁸ According to JRM, at low frequencies, ions can hop to adjacent sites, resulting in long-range translational motion that contributes to DC conductivity, which is sustained over a long period. However, in the high-frequency range, hopping can result in either successful or unsuccessful outcomes.

In unsuccessful hopping, the hopping ion can move back and forth before returning to its initial position, whereas in successful hopping, the excited hopping ion jumps to a new site and remains stationary, causing the surrounding ions to relax. At high frequencies, the proportion of unsuccessful to successful hopping increases, resulting in dispersive conductivity. The measured electrical conductivity is attributed to Jonscher's power law and the universal dielectric response (UDR) model developed by Jonscher:⁴⁹

$$\sigma_{AC}(\omega) = \sigma_{DC} + \sigma_0 \omega^s \quad (15)$$

The total conductivity comprises DC and AC contributions denoted by σ_{DC} and σ_{AC} , respectively, while σ_0 is a constant and the frequency exponent is represented by the parameters. The parameter “*s*” reflects the extent to which charge carriers interact with the lattice of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) and falls within the range of 0 to 1.

The experimental data of the $\sigma_{AC}(\omega)$ variation (Fig. 9(a) and (b)) were fitted using the UDR approach to determine the σ_{DC} values at all temperatures for both materials. Based on Fig. 9(c) ($\ln(\sigma_{DC})$ vs. $1000/T$), the average activation energies of $\text{Cs}_2\text{-MBiCl}_6$ ($M = \text{Ag, Cu}$) can be calculated using the following Arrhenius equation:

$$\sigma_{DC} = \sigma_0 e^{\frac{-E_a}{k_B T}} \quad (16)$$

where the activation energy is denoted by E_a , the pre-exponential factor is denoted by σ_0 , the Boltzmann constant is denoted by k_B , and the absolute temperature is denoted by T .

The activation energy values for $\text{Cs}_2\text{AgBiCl}_6$ and $\text{Cs}_2\text{CuBiCl}_6$ are 0.236 eV and 0.359 eV, respectively. It should be noted that these values are similar to those obtained from the modulus analysis.

A proposed pattern for understanding the charge transfer mechanism in $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) can be developed by

considering various theoretical approaches related to the evolution of $s(T)$. In the literature, several models have been suggested based on different methods, such as quantum mechanical tunneling, typical barrier hopping, or a combination of the two, which are consistent with the data. Furthermore, it is hypothesized that there are different types of carriers, such as electrons (or polarons) or atoms. Various theoretical approaches are proposed based on quantum mechanical tunneling, typical barrier hopping, or a combination of the two, which include overlapping large polaron tunneling (OLPT), non-overlapping small-polaron tunneling (NSPT), correlated barrier hopping (CBH), and quantum mechanical tunneling (QMT).^{50–53} Fig. 9(d) displays the temperature-dependent variation of the exponent ‘*s*’ for $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) double perovskite materials:

- For $\text{Cs}_2\text{AgBiCl}_6$, as the parameter ‘*s*’ decreases with increasing temperature to a minimum value and then slightly increases, it suggests that the OLPT approach is suitable.
- For $\text{Cs}_2\text{CuBiCl}_6$, since the parameter ‘*s*’ increases with temperature, the NSPT approach is deemed appropriate.

When a localized charge approaches the material, polarons are formed and they move to the nearest adjacent positions. Once a polaron reaches a new configuration, it can remain stable in that position after a successful hop, or it can shift back to its original position after an unsuccessful hop. The non-dispersive behavior of AC conductivity in the low-frequency region is due to successful polaron hopping. However, at higher frequencies, an increasing number of hops become unsuccessful, leading to dispersive (AC) conductivity. It is suggested that in many perovskite compounds, the formation of a polaron occurs *via* lattice deformation,²⁷ which is not accounted for in electron tunneling models. Creating polarons can cause a significant distortion in the local lattice, due to the high degree of charge transport at a site. This distortion can be so significant that it prevents the overlapping of polaron clouds. At higher temperatures, the (AC) conductivity is attributed to confined polarons at structural defects or carrier tunneling.¹⁸

The OLPT approach interprets the (AC) conductivity as the process of polaron tunneling, which occurs when the polaron distortion clouds overlap. In the case of large polarons, the interatomic spacing is smaller than the spatial extent of the polaron. In some instances, the long-range Coulomb interaction results in the overlap of the potential wells at nearby sites, reducing the polaron hopping energy. As a result, the loss is affected by the frequency, and the activation energy associated with the motion of charge carriers between different sites decreases, as shown in eqn (17):⁵⁰

$$W_H = W_{H0} \times \left(1 - \frac{r_p}{R}\right) \quad (17)$$

The energy required for polaron hopping is denoted by W_H , while r_p indicates the radius of the large polaron. It should be noted that W_H represents the polaron hopping energy.

Eqn (18) demonstrates the expression for the energy W_{H0} :⁵¹

$$W_{H0} = \frac{e^2}{4\epsilon_p r_p} \quad (18)$$



The effective dielectric constant is denoted by the parameter ϵ_p . Within this model, the variable intersite separation R is considered, while the energy W_{H0} remains constant across all sites.

The expression for the AC conductivity is presented below:⁵²

$$\sigma_{ac} = \frac{\pi^4 e^2 k_B^2 T^2 \alpha^{-1} \omega [N(E_F)]^2 R_\omega^4}{12(2\alpha k_B T + W_{H0} r_p / R_\omega^2)} \quad (19)$$

The equation below defines the hopping length R_ω :

$$(R'_\omega)^2 + (\beta W_{H0} + \ln(\omega \tau_0)) R'_\omega - \beta W_{H0} r'_p = 0 \quad (20)$$

The inverse localization length is denoted by the parameter α , $R'_\omega = 2\alpha R_\omega$, $\beta = 1/k_B T$ and $r'_p = 2\alpha r_p$.

The following expression defines the parameter s within this approach:⁵³

$$s = 1 - \frac{8\alpha R_\omega + \frac{6W_{H0} r_p}{R_\omega k_B T}}{\left[2\alpha R_\omega + \frac{W_{H0} r_p}{R_\omega k_B T}\right]^2} \quad (21)$$

According to eqn (19), the theoretical calculations based on the OLPT model (shown in Fig. 10(a)) are consistent with the experimental measurements. The OLPT model parameters obtained from eqn (17) and (18) are listed in Tables 4 and 5. The values of parameter α fall within the same range as reported by Murawski *et al.*⁵⁴ Moreover, the $N(E_F)$ values are reasonable for localized states. The frequency dependence of the parameter R_ω ($\text{Cs}_2\text{AgBiCl}_6$) is shown in Fig. 10(b). It is interesting to note that the tunneling distances R_ω (3.729–3.821 Å) are in close proximity to the interatomic distances Cs–Cl (3.810 Å) within $\text{Cs}_2\text{AgBiCl}_6$. These findings may indicate that the mobility of Cs^+ cations facilitates AC conductivity through large polaron motion.⁵⁵

The parameter s is expressed as follows within the NSPT approach:⁵⁴

$$s = 1 + \frac{4k_B T}{W_m - k_B T \ln(\omega \tau_0)} \quad (22)$$

The activation energy for polaron transfer is denoted by W_m . k_B represents the Boltzmann constant, and τ_0 represents the characteristic relaxation time (approximately 10^{-13} s).

The following equation expresses the parameter s for large values of $W_m/k_B T$:

$$s = 1 + \frac{4k_B T}{W_m} \quad (23)$$

The value of W_m (corresponding to 0.146 eV) was obtained by curve fitting for $\text{Cs}_2\text{CuBiCl}_6$ (as shown in Fig. 9(d)). It should be noted that, in this approach, the value of W_m is independent of the intersite separation since the small polarons are confined in such a way that their cloud distortions do not interfere.¹⁷

The following equation expresses the AC conductivity within the NSPT approach.¹⁸

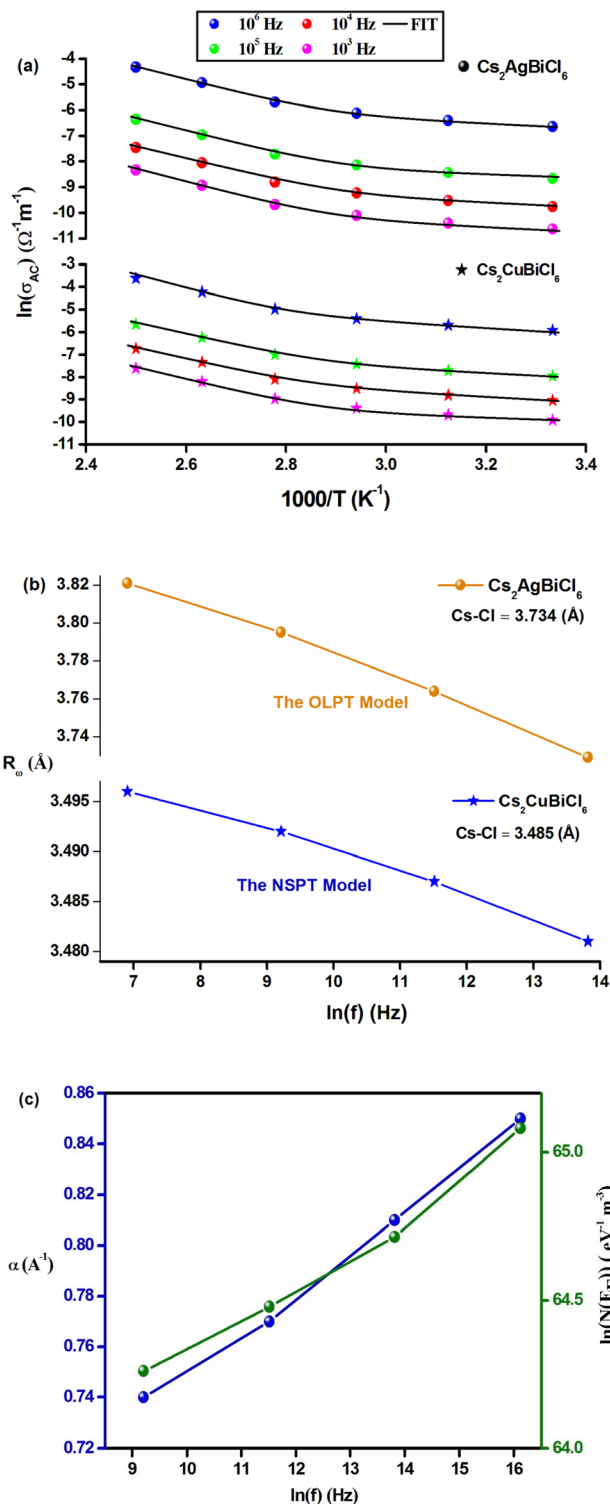


Fig. 10 (a) Temperature dependence of the $\ln(\sigma_{AC})$ at different frequencies. (b) Frequency-dependent of the parameter R_ω (Å) for $\text{Cs}_2\text{MBiCl}_6$ (M = Cu, Ag). (c) Frequency-dependent of the parameters α (Å^{-1}), $N(E_F)$ ($\text{eV}^{-1}\text{cm}^{-3}$).

$$\sigma_{ac} = \frac{(\pi e)^2 k_B T \alpha^{-1} \omega [N(E_F)]^2 R_\omega^4}{12} \quad (24)$$



Table 4 Parameters of the OLPT model at varying frequencies

Frequency (Hz)	α (\AA^{-1})	W_{HO} (eV)	N (cm^{-3})	r_p (\AA)	R_ω (\AA)
10^3	0.71	0.654	2.24×10^{25}	1.309	3.821
10^4	0.80	0.606	3.78×10^{25}	1.293	3.795
10^5	0.84	0.572	5.99×10^{25}	1.276	3.764
10^6	0.86	0.511	8.36×10^{25}	1.247	3.729

Table 5 The values of ϵ_p and W_H were determined at various frequencies

Frequency (Hz)	ϵ_p (F m^{-1})	W_H (eV)
10^3	6.28×10^{-9}	0.367
10^4	7.06×10^{-9}	0.335
10^5	7.77×10^{-9}	0.318
10^6	8.45×10^{-9}	0.300

Table 6 Parameters of the NSPT model at various frequencies

Frequency (Hz)	α (\AA^{-1})	$N(E_F)$ ($\text{eV}^{-1} \text{cm}^{-3}$)	R_ω (\AA)
10^3	0.74	8.09×10^{27}	3.912
10^4	0.77	1.00×10^{28}	3.909
10^5	0.81	1.27×10^{28}	3.906
10^6	0.85	1.84×10^{28}	3.903

where

$$R_\omega = \frac{1}{2\alpha} \left[\ln\left(\frac{1}{\omega\tau_0}\right) - \frac{W_m}{k_B T} \right] \quad (25)$$

The AC conductivity is determined by the following equation in the NSPT approach, where $N(E_F)$ represents the density of states near the Fermi level, α^{-1} denotes the spatial extension of the polaron, and R_ω refers to the tunneling distance. The variation of $\ln(\sigma_{\text{AC}})$ with temperature is shown in Fig. 10(a). It is evident from this figure that the fit is in good agreement with the experimental measurements ($\text{Cs}_2\text{CuBiCl}_6$). Table 6 shows all NSPT model parameters, which were obtained from the fitting of the data points. It should be noted that the $N(E_F)$ values are reasonable for localized states.¹⁷ The frequency dependence of the parameters $N(E_F)$ and α are shown in Fig. 10(c), where it is observed that both parameters decrease as the frequency increases. This trend is consistent with previous reports.²⁵ The corresponding values of the tunneling distance ' R_ω ' obtained from eqn (25) are presented in Table 6.

Fig. 10(b) demonstrates the frequency dependence of R_ω ($\text{Cs}_2\text{CuBiCl}_6$), indicating a decrease in the hopping distance with increasing frequency. This trend suggests that charge carriers move from long-distance to short-distance tunneling, which could account for the observed increase in $N(E_F)$ ($\sim 10^{28} \text{eV}^{-1} \text{cm}^{-3}$) with frequency.¹⁸ It is noteworthy that the tunneling distances R_ω (3.903–3.912 \AA) are similar to the interatomic distances Cs–Cl (3.910 \AA) within $\text{Cs}_2\text{CuBiCl}_6$. This observation implies that the mobility of Cs^+ cations facilitates AC conductivity *via* a small polaron motion.⁵⁵

As a part of this work, we investigated the electrical and optical characteristics of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$). Based on the available literature,^{56,57} it has been observed that the CBM (conduction band minimum) in the $\text{Cs}_2\text{AgBiCl}_6$ compound primarily originated from the Cl-3p, Bi-6p, and Ag-5s orbitals, with a minor contribution from the Ag-4d orbital. Conversely, the VBM (valence band maximum) mainly consists of Ag-4d and

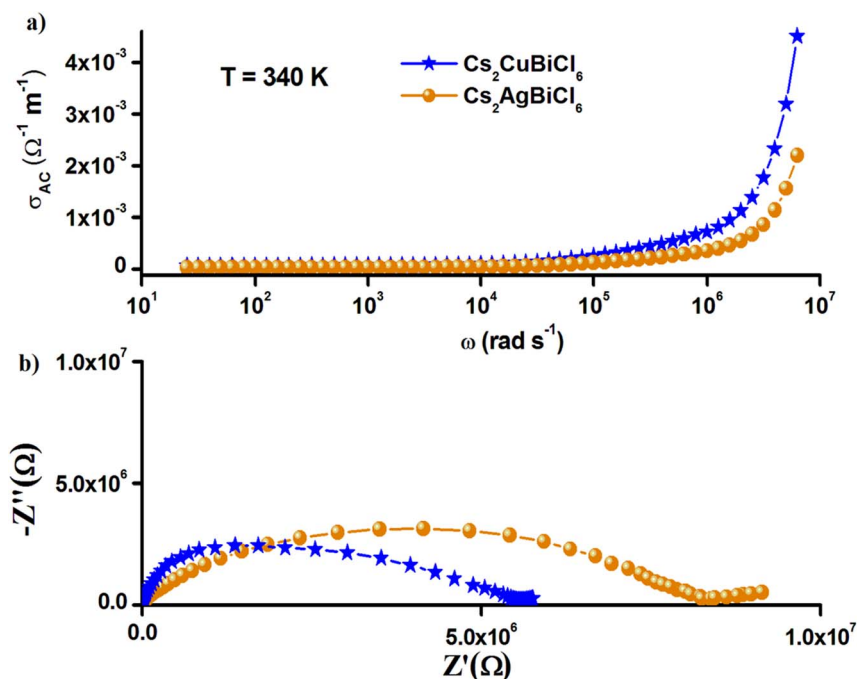


Fig. 11 (a) Nyquist diagram and (b) AC conductivity of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Cu, Ag}$) at 340 K.



Cl-3p orbitals, with a minimal contribution from the Bi-6s orbitals. In the case of $\text{Cs}_2\text{CuBiCl}_6$, which contains copper instead of silver, a significantly smaller indirect bandgap of 1.31 eV has been reported, with the CBM located at the T symmetry point and the VBM at the X point. According to the literature, the CBM in $\text{Cs}_2\text{CuBiCl}_6$ is predominantly composed of Cl-3p, Bi-6p, Cu-4s, and Cu-3d orbitals, while the VBM consists mainly of Cu-3d, Cl-3p, and Bi-6s orbitals. It is worth noting that despite both compounds having a cubic double perovskite phase, $\text{Cs}_2\text{AgBiCl}_6$ exhibits a considerably larger indirect bandgap energy of 2.92 eV compared to $\text{Cs}_2\text{CuBiCl}_6$ (1.31 eV). This variation in the bandgap energy between $\text{Cs}_2\text{-MBiCl}_6$ (where $M = \text{Ag, Cu}$) can be attributed to the change in the metal component, as the semiconductor characteristics are closely linked to the structural arrangement.

Furthermore, the Nyquist plots and the frequency-variation (AC) conductivity of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) at 340 K, shown in Fig. 11, show that the larger conductivity is noted in $\text{Cs}_2\text{-CuBiCl}_6$. The electrical and optical (bandgap) characteristics are related to the structure of $[\text{BiCl}_6]^{3-}$ and $[\text{MCl}_6]^{5-}$ ($M = \text{Ag, Cu}$) octahedra and their coupling. This can be explained by the structural difference between these two compounds, precisely at the level of the anion $[\text{MCl}_6]^{5-}$ ($M = \text{Ag, Cu}$). Due to the Jahn-Teller effect, the copper coordination octahedra in $\text{Cs}_2\text{CuBiCl}_6$ are usually distorted, thus changing the energetics of the different bonds in the crystal structure. We can then think that the delocalization of charge carriers within the $\text{Cs}_2\text{CuBiCl}_6$ compound is easier, which favors the increase in their AC conductivity.

4. Conclusions

To summarize, the slow evaporation solution growth method was used to synthesize $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) double perovskites. The X-ray diffraction pattern confirmed that the compounds have a cubic symmetry. The indirect bandgap energies were determined to be 1.31 eV and 2.92 eV for $\text{Cs}_2\text{-CuBiCl}_6$ and $\text{Cs}_2\text{AgBiCl}_6$, respectively. The double-layer Maxwell-Wagner effect has been proposed as the explanation for the significant change in relative permittivity in $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$). The free charge and space-charge conductivity were evaluated using the modified Cole-Cole plot and were found to increase as the temperature increased. The analysis of the Nyquist curves supported the presence of grain, grain boundaries, and electrode processes. The KWW model was used to evaluate the asymmetric plots of the modulus formalism for both materials. The non-Debye behavior of $M''(\omega)$ decreased with increasing temperature. The activation energy was calculated from DC conductivity and the modulus spectra for each material, which showed similar values. This suggests that the conduction mechanism and the relaxation behavior are similar in $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$). The AC conductivity of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) was investigated using Jonscher's power law. The OLPT and NSPT models were used to interpret the conduction mechanisms for $\text{Cs}_2\text{AgBiCl}_6$ and $\text{Cs}_2\text{CuBiCl}_6$, respectively, based on Elliot's theory. The results from these models suggest that the AC conductivity in $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) is facilitated by

the mobility of Cs^+ cations through the tunneling mechanism. The favorable energy band gap, conductivity, relaxation time, and dielectric constant of $\text{Cs}_2\text{MBiCl}_6$ ($M = \text{Ag, Cu}$) make it a promising material for energy-harvesting systems.

Conflicts of interest

There are no conflicts to declare.

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